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Solvothermal Synthesis and Characterization of Indium Oxide Nanoparticles

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Abstract

In this study, In_2O_3 was prepared by Solvothermal technique in autoclave device, which is a simple and inexpensive technique to indicate the best condition. The reaction took place between indium chloride and urea. $\text{In}(\text{OH})_3$ as-prepared annealing at 100°C and convert to In_2O_3 at annealing temperatures 300, 500, 700°C for 90 min. The physical properties of nanoparticles were characterized by XRD, SEM, AFM, UV/Visible and FTIR spectroscopy measurements. The examination results of XRD for In_2O_3 powder annealed at different temperature showed the formation of a cubic phase of nanoparticles with high intensity of plane (222). The lattice constant decreases with the increase of annealing temperature (from 10.07 to 10.04 \AA). AFM indicated an increase in grain size of In_2O_3 with increasing of annealing temperatures (from 78.59 to 94.4 nm). The optical properties, transmittance of In_2O_3 nanoparticles at annealing temperatures 500°C have a high transparent reach to (89%) and Energy gap Increases with increasing annealing temperature in range (3.6 to 4.65 eV).

Keywords: Indium oxide (In_2O_3), Solvothermal, cubic structure, transmittance.

دراسة الخصائص لأوكسيد الأندسيوم النانوية

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الخلاصة

في هذا البحث، تم تحضير اوكسيد الانديوم بتقنية الضغط الحراري باستخدام جهاز الأوتوكليف ، وهي تقنية سهلة ورخيصة للحصول على افضل تفاعل بين كلوريد الانديوم و اليوريا. تم تحويل هايدروكسيد الانديوم الملدن بدرجة حراره 100°C الى اوكسيد الانديوم عند درجات الحراره 300، 500، 700°C لفته 90 دقيقة. شخصت الخواص الفيزيائية للجسيمات النانوية بواسطة قياسات حيود الأشعة السينيه ، المجهر الإلكتروني الماسح مجهر القوة الذرية، الأشعة فوق البنفسجية/المرئية و مطيافية الأشعة تحت الحمراء. اظهرت نتائج فحص حيود الأشعة السينية للجسيمات الملدنة عند الدرجات الحرارية المختلفة الى تكون الطور المكعبي للتركيب البلوري لأوكسيد الأندسيوم مع ظهور شدة عالية للقمة (222) وتبين ان ثابت الشبكة يقل بزيادة درجة حرارة التلدين (من 10.07 الى 10.04 انكستروم). بينت نتائج فحوصات مجهر القوة الذرية هناك زيادة في

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الحجم الحبيبي لأكسيد الانديوم (من 78.59 الى 94.4 نانومتر) مع زيادة درجة حرارة التلدين. اظهرت الخصائص البصرية ان اوكسيد الانديوم النانوي انة يمتلك نفاذية عالية تصل الى (89%) عند درجة تلدين (500 م°) و زيادة فجوات الطاقة مع زيادة درجات حرارة التلدين لتتراوح (3.6-4.65 إلكترون فولت).

1. Introduction

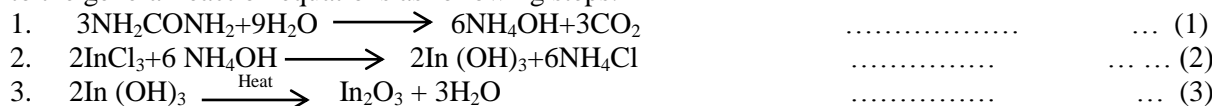
Indium oxide (In_2O_3) is among the important transparent conducting materials (TCO), Indium oxide (In_2O_3) is an n-type semiconductor which has high transparency (>70%) to visible light [1] and wide band gaps of (3-4.5 eV) [2]. The structure of In_2O_3 in its crystalline form is body centered cubic with lattice constant $a = 10.118 \text{ \AA}$. It can be prepared by a variety of techniques such as chemical vapor deposition [3], pulsed laser deposition [4], sol-gel [5] and hydro-thermal [6, 7]. The application of nanoparticle of In_2O_3 was found in many technological applications in electronic devices of various types like: transparent windows in liquid crystal displays, anti-refraction coatings, electro chromic devices [3], liquid crystal displays [8], gas sensors, solar cells and photovoltaic devices [9,10]. The gas-sensing materials have been used for detecting various gasses, such as ammonia, ethanol, hydrogen, methane, butane and carbon monoxide [7, 11].

The crystalline structure, morphology and particle size of the In_2O_3 were investigated using XRD, SEM, AFM, UV-visible and FTIR spectroscopy measurements and electrical properties for In_2O_3 nanostructures.

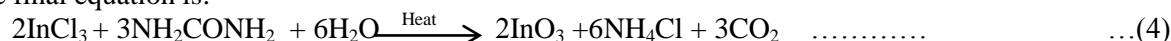
2. Experimental part

Indium oxide nanoparticles were synthesized by Solvothermal technique using autoclave, by reaction of indium chloride with urea. Indium chloride (InCl_3) (3 g) dissolved in distilled water. The solution was stirred with a magnetic stirrer at 25 °C for 10 min in a beaker until it became colorless. Meanwhile, in another beaker, urea (NH_2CONH_2), (1.2260 g) dissolved in distilled water. The solution was stirred with a magnetic stirrer at 25 °C for 10 min in a beaker until it became colorless. The two solutions were mixed and stirred with a magnetic stirrer at 25 °C for 20 min until it became colorless, after that the mixed solutions were added into a 50 ml Teflon-lined autoclave. The autoclave was sealed and put into an oven at 200 °C for 5 h. Then, the autoclave was allowed to cool to room temperature naturally. The white precipitate ($\text{In}(\text{OH})_3$) was washed with distilled water (about 5 times), and collected by centrifugation, washed with ethanol (2 times) and annealing at the different temperature (100,300,500,700 °C) for 90 min, After annealing at (300, 500, 700 °C), the powder convert to yellow color (In_2O_3), this shown in Figure-2.

The reaction took place between the indium chloride and urea to product white precipitate according to the general reaction equations as following steps:



The final equation is:



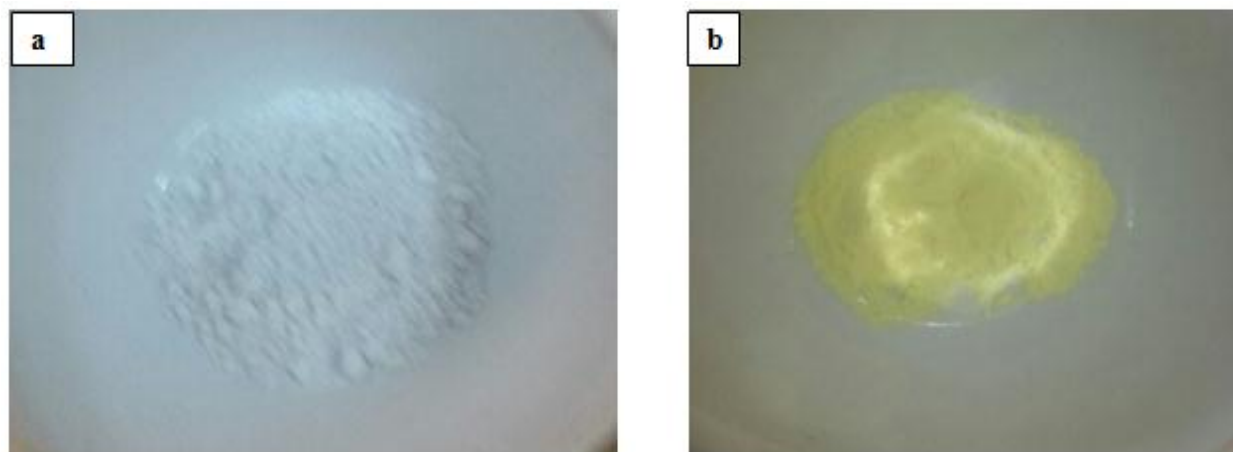


Figure 1- a) indium hydroxide at 100°C, b) indium oxide at 300°C

3. Results and Discussion

Figure -2 show XRD for indium oxide In_2O_3 . The annealing temperature is the important effect on the structure of indium oxide nanoparticles. The XRD pattern can be well indexed the phase structure of the $\text{In}(\text{OH})_3$ and its thermally manufactured products (In_2O_3) at (100°C), Figure-2(a) shows four diffraction peaks (200),(220),(420) and (422) at ($2\theta=22.4276, 31.8188, 51.2987$ and 56.6070°), All XRD patterns correspond well to the bcc structure of indium hydroxide $\text{In}(\text{HO})_3$ according to the (JCPDS Card No.16-0161). The annealing at (300°C) convert $\text{In}(\text{OH})_3$ to In_2O_3 so another different peaks appears (200),(222), (440) and (400) at($2\theta=21.6260,30.7057, 51.1266$ and 35.5837°) this shows in Figure-2(b). The annealing at (500°C) Figure-2(c) shows different peaks (200), (222), (440) and (400) at ($2\theta=21.6681, 30.7517, 51.1982$ and 35.6324°). The annealing at (700°C) Figure-2(d) shows different peaks (200), (222), (440) and (400) at ($2\theta=21.7106, 30.8050, 51.2514$ and 35.6800°), respectively that are close to the values of the reference data (JCPDS Card No: 44-1087.). The intensity ratio of the peaks (200), (440) and (400) decreases and increases in (222) orientation when the annealing temperature was increased. The crystallite size and the energy of the surface species increases with increasing annealing temperature [3].

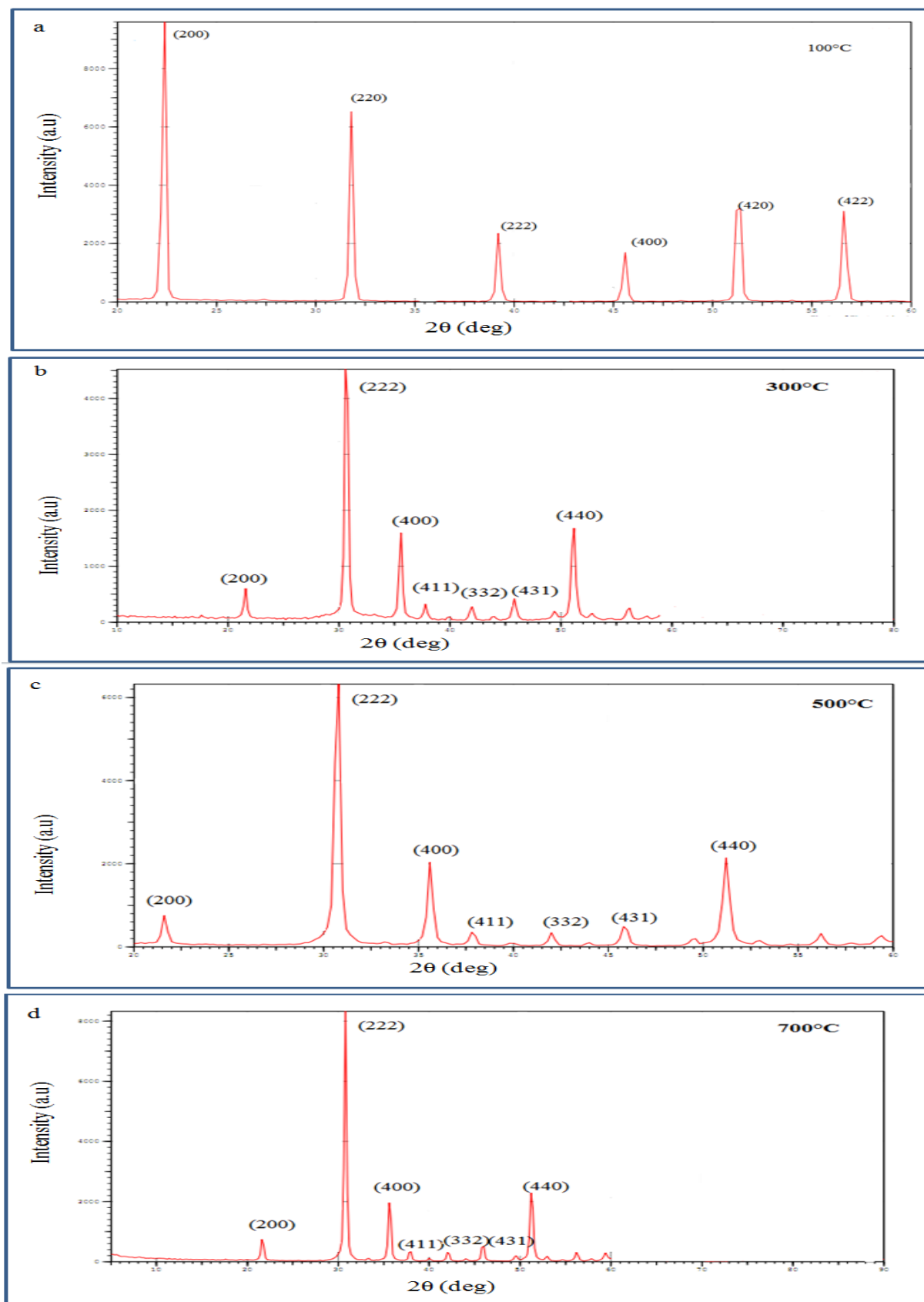


Figure 2- XRD patterns of $\text{In}(\text{OH})_3$ at annealing temperature (a) 100°C , XRD patterns of In_2O_3 at annealing temperature: (b) 300°C , (c) 500°C and (d) 700°C .

Figure- 3(a) shows FTIR spectrum of the indium hydroxide (as-prepared). In this spectrum, a strong absorption bands around 3500 and 1635 cm^{-1} characterized of OH stretching and bending absorbed water respectively, because of the difficulty of removing the water residue completely [12]. The annealed sample at 300°C, Figure-3(b), three main strong peaks centered at 601, 565 and 418 cm^{-1} were observed, that are characteristic of the In-O and In-O-In stretching respectively, when the annealing temperatures increase to 500 and 700 C, Figures-3(c and d), four main strong peaks around 601, 565, 540 and 426 cm^{-1} were observed, those are characteristic of the In-O, In-In and In-O-In stretching respectively [7]. The absorption bands around 3500 and 1635 cm^{-1} become undistinguished because the samples lose the moist (H_2O).

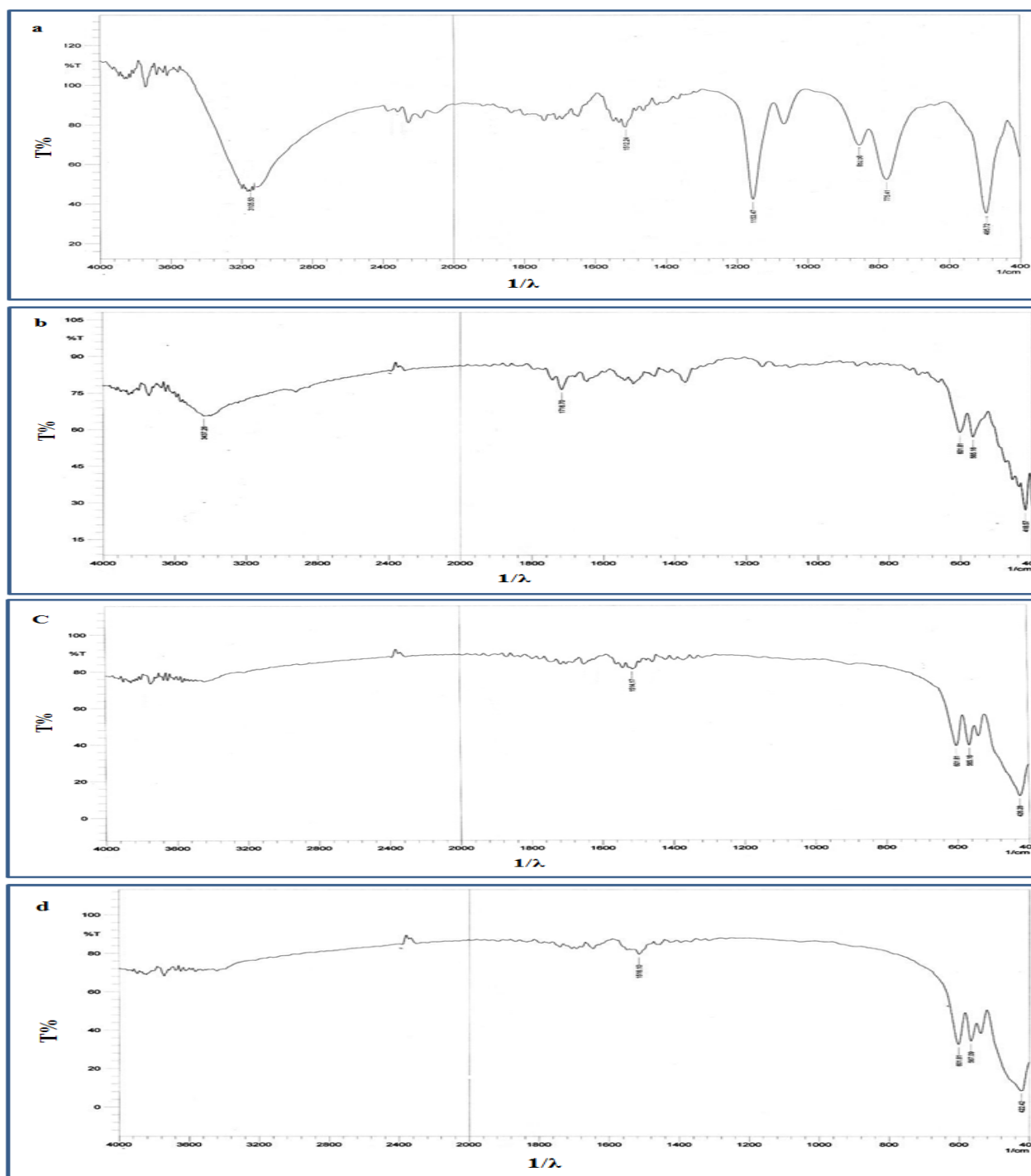


Figure 3- FTIR transmittance spectra of In_2O_3 at different annealing temperature: (a) 100°C, (b) 300°C, (c) 500°C and (d) 700°C as a function of wavenumber.

Figure-4 shows a typical two and three-dimensional AFM image of In_2O_3 nanoparticles with annealing at (a-100, b-300, c-500, and d-700) $^\circ\text{C}$. The average grain size is found to be (78.59-93.81nm). AFM results show that the grain size increases by increasing temperature due to improving the crystallinity of the nanoparticles [3]. Figure -5 shows the granularity cumulation distribution chart of In_2O_3 with annealing at (a-100, b-300, c-500, and d-700) $^\circ\text{C}$.

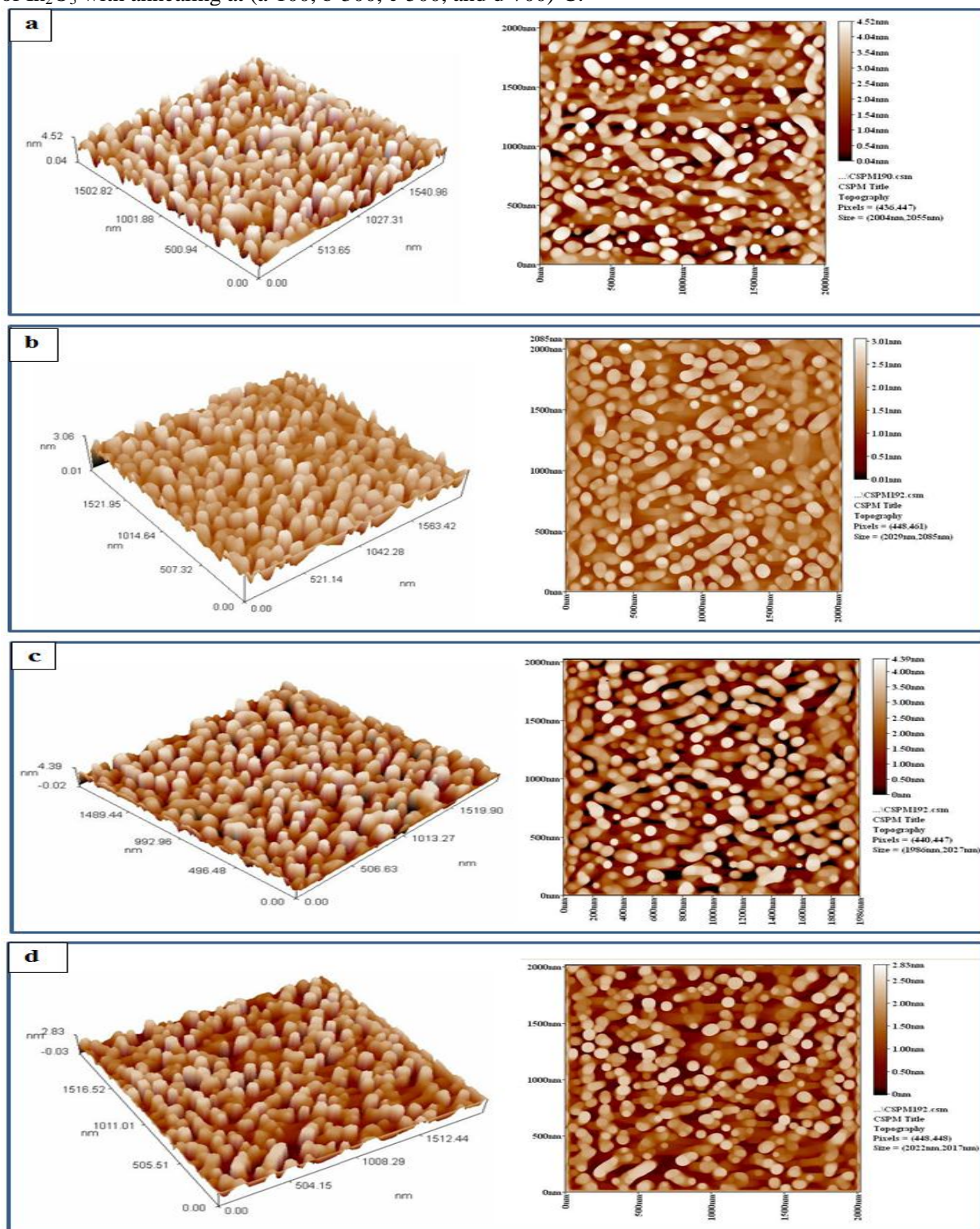


Figure 4- (3-D and 2-D AFM images of In_2O_3 at different annealing temperatures: (a) 100 $^\circ\text{C}$, (b) 300 $^\circ\text{C}$, (c) 500 $^\circ\text{C}$ and (d) 700 $^\circ\text{C}$ for 90 min.

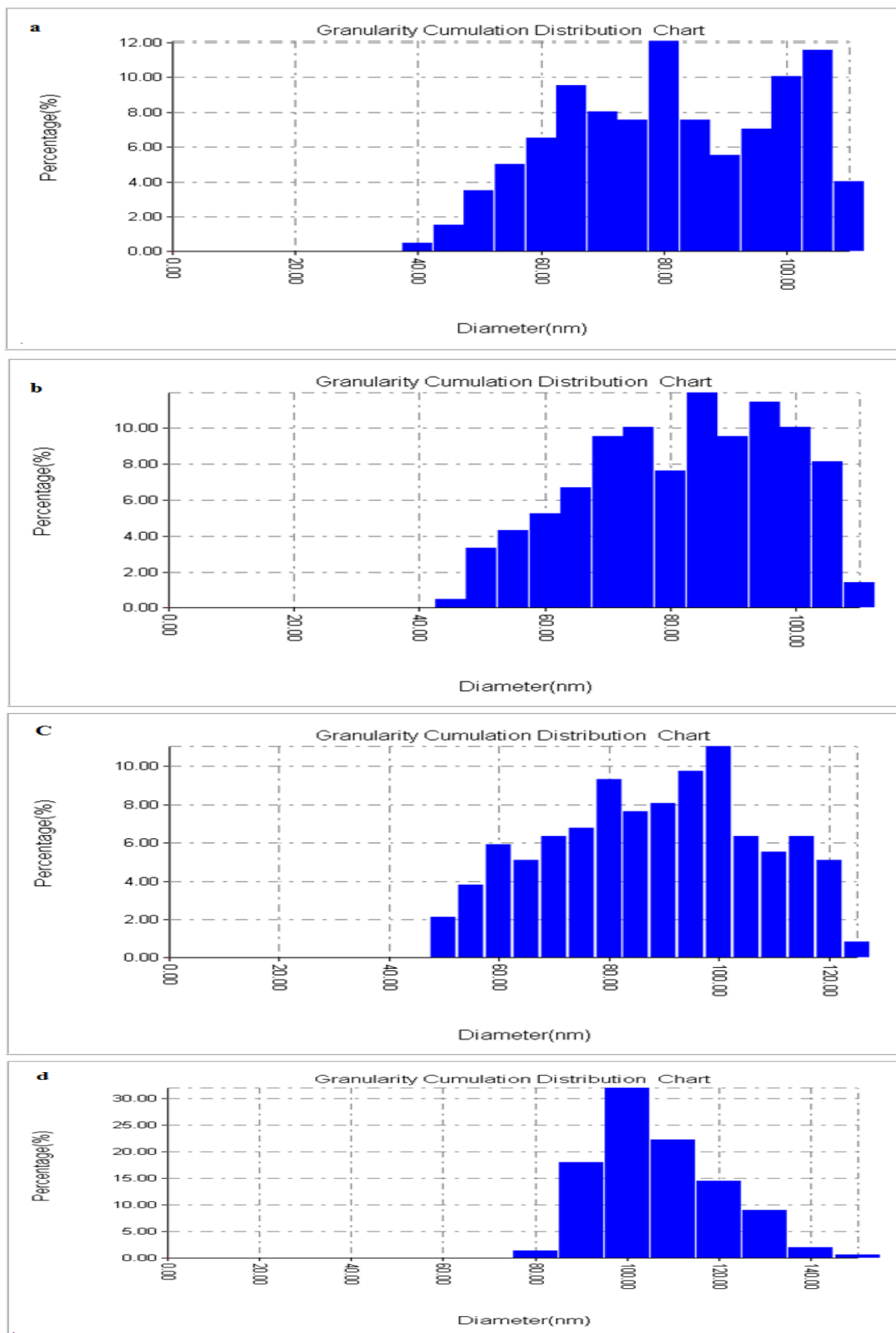


Figure 5- Granularity cumulation distribution chart of In_2O_3 a: 100°C, b: 300°C c: 500°C and d: 700°C.

Figure-6 shows the SEM images of In_2O_3 . According to the SEM photographs, the shapes are cubic, increasing temperature effects on the surface morphology, especially grains dimension and improved in structure and the uniformity of the nanoparticle enhanced [3]. The grain size is increasing with increasing temperature, which is found to have agglomerated crystallites within each grain and cluster, irregular surface morphology was observed [13].

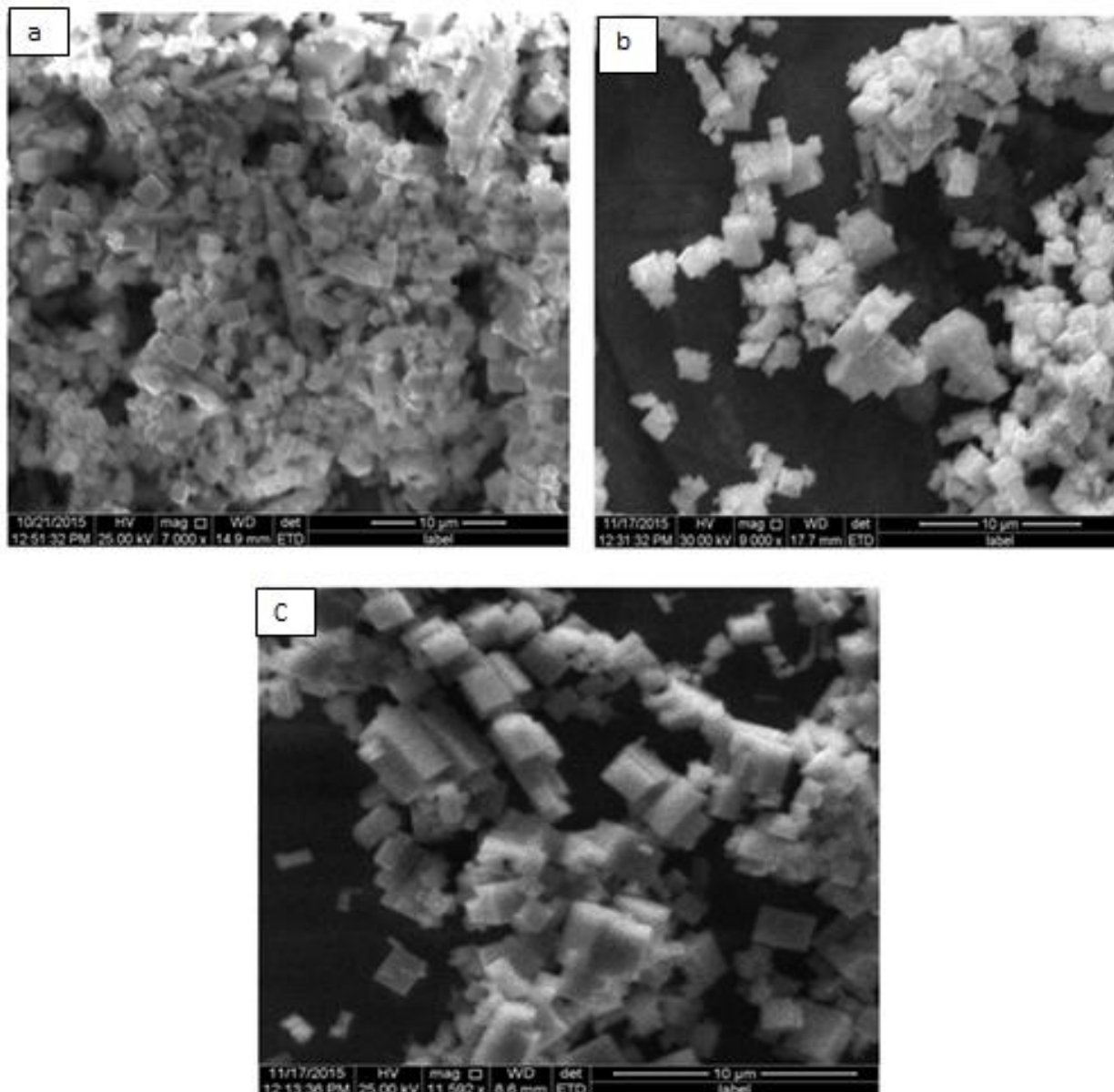


Figure 6 - SEM images for In_2O_3 nanoparticle at a: 100°C, b: 300°C and C: 500°C.

Figure-7 shows the optical transmittance curves as a function of the wavelength for the In_2O_3 nanoparticles at various annealing temperatures (100, 300, 500 and 700)°C for (90 min). It can be observed that the optical transmittance increases with increasing annealing temperature. The optical transmittance changed from (20% to 89%) with the increase of annealing temperature [3]. The highest transmittance value is about (89%) in the UV-Visible region for the In_2O_3 nanoparticles at 500°C. The increase in transmittance is attributed to high crystallinity, structural homogeneity and improvement in the lattice constant. In the case of higher annealing temperatures above 500°C, there is a drop in transmittance due to the increased irregularity and impaired crystallinity and leads to films with less stoichiometry [13].

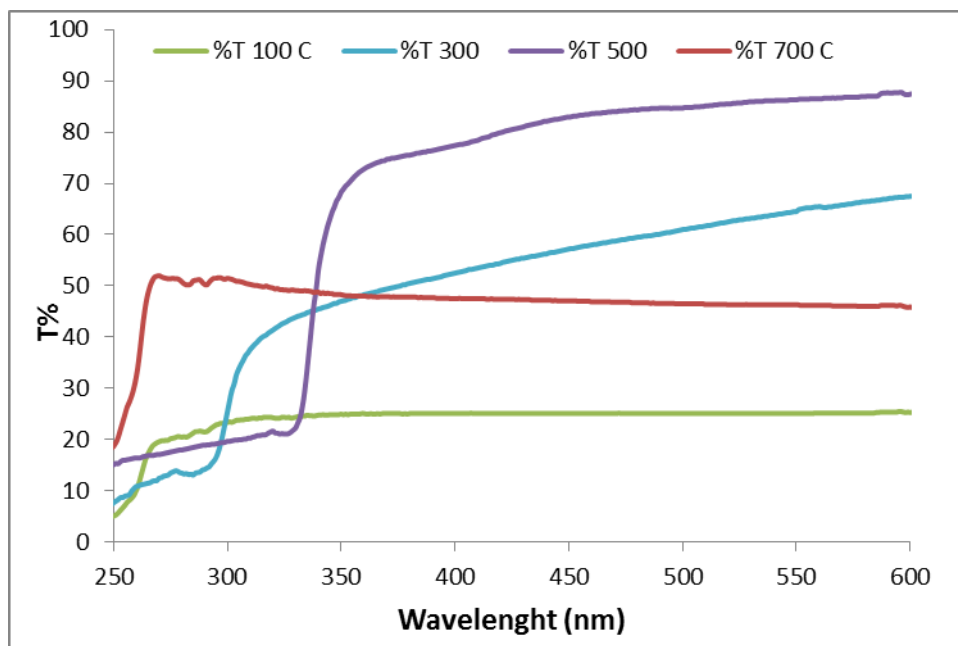
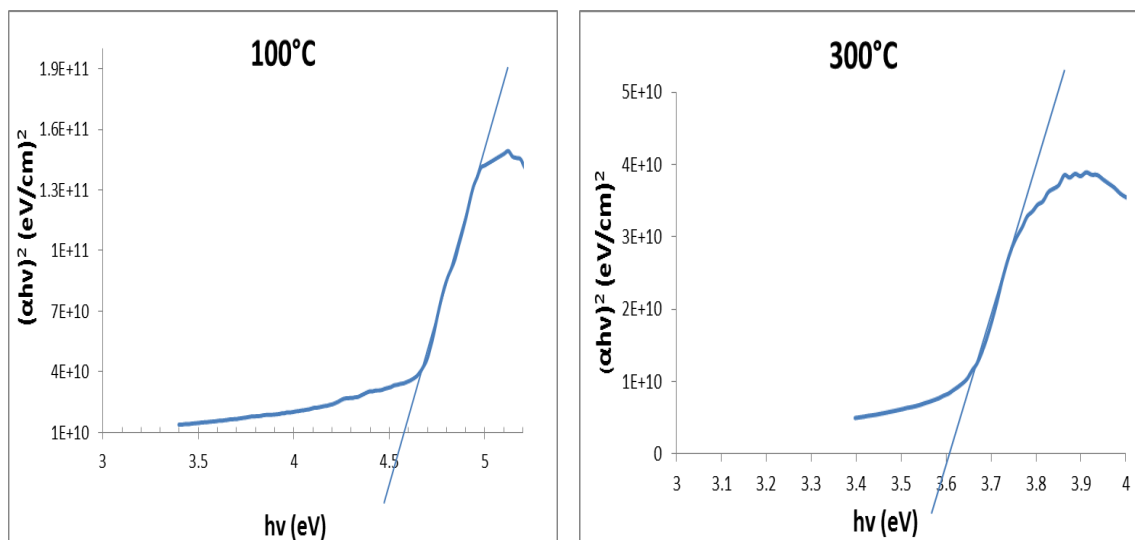


Figure 7- The optical transmittance spectra for indium oxide (In_2O_3) at different annealing temperatures (100, 300, 500 and 700 °C).

Figure-8 shows the optical band gap of the In_2O_3 nanoparticle. The optical band gap of In_2O_3 nanoparticle is increases with increasing annealing temperature at (300,500 and 700)°C, this is due to improvement of crystallinity and decreasing in the oxygen deficiency [14]. The high value of band gap confirms the surface smoothness and uniformity of $\text{In}(\text{OH})_3$ annealed at 100°C. Annealed In_2O_3 nanoparticles at 500°C have a band gap of 3.65 eV [13].



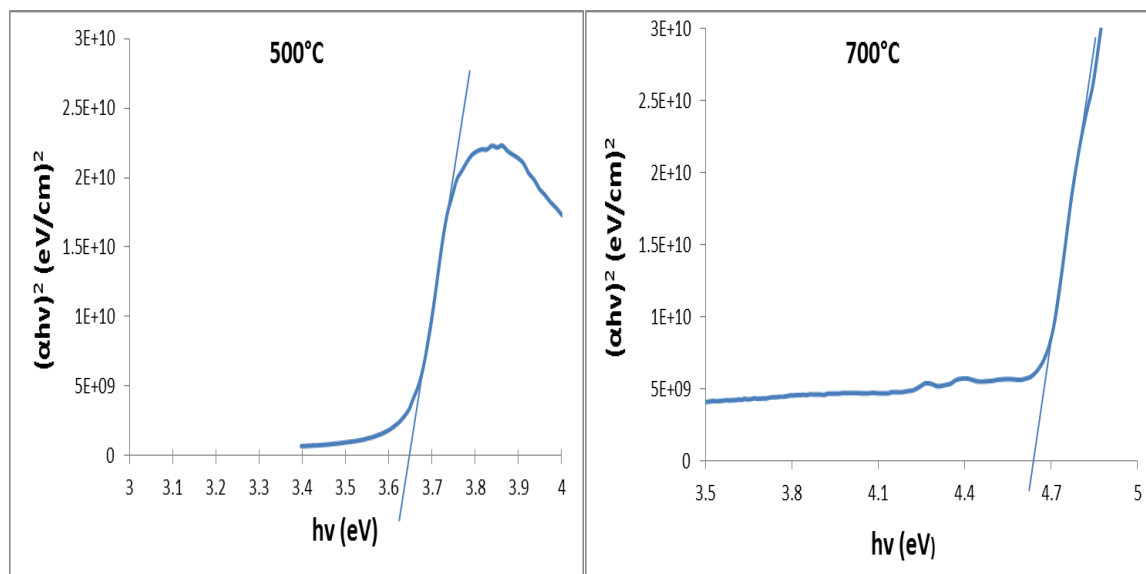


Figure 7- The optical band gap for indium oxide (In_2O_3) at different annealing temperature (100, 300, 400 and 700 °C).

4. Conclusions

In conclusion, we have presented experimental study of the growth of (CdO) thin films using oblique angle deposition. Structural, morphological, optical, thermoelectrically and electrical properties are found to be dependent on the oblique deposition angle. This study was focused on the Indium oxide that annealing temperature (300, 400 and 700°C), and the size of In_2O_3 nanoparticles obtained by Solvothermal technique starting with indium chloride and urea in autoclave device. The annealing In_2O_3 nanoparticles were characterized by XRD, AFM, SEM, UV/Visible and FTIR spectroscopy measurements. XRD and SEM found that the In_2O_3 have cubic crystallites crystal structure with high intensity of plane (222). We notice that the size of nanoparticles is in direct relationship with the increase of the temperature annealing from 78.59 to 94.4 nm.

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